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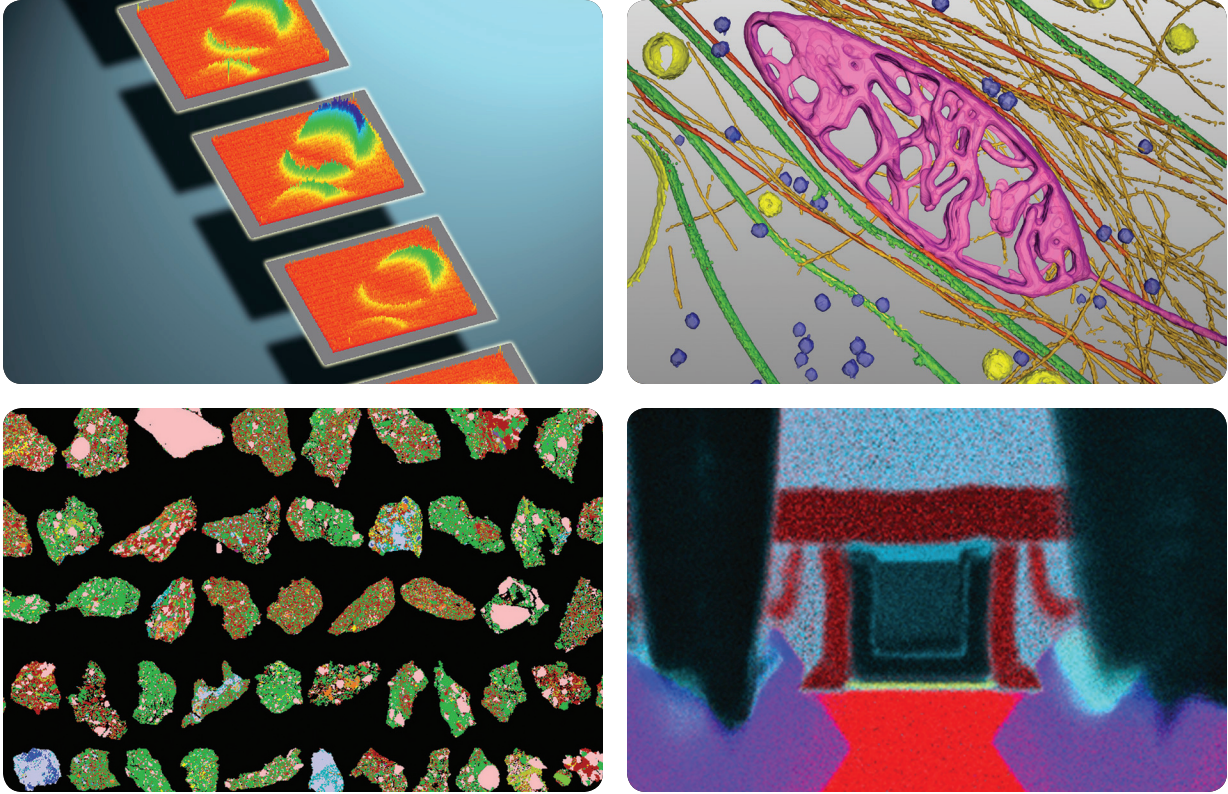
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(Top left) Ultra-fast electron microscopy images of the evanescent field surrounding a protein sphere. Image courtesy of David J. Flannigan, Department of Chemical Engineering and Materials Science, University of Minnesota. **(Top right)** Surface rendered cryo electron tomogram of mouse fibroblast cell. Courtesy of Roman Koning. **(Bottom left)** Drill cuttings from a CO₂ injection well. Courtesy CO2CRC, Australia. **(Bottom right)** 600 × 600 pixel maps, fully quantified, of a 45 nm PMOS transistor structure. Courtesy of D. Klenov, FEI NanoPort, The Netherlands.

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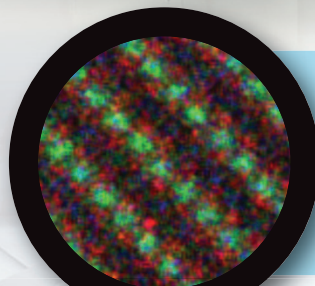
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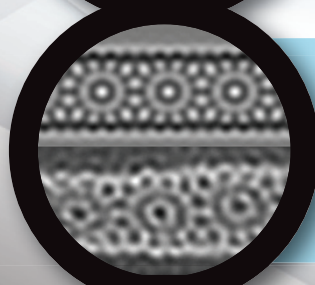
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Dr. John Bradley
University of Hawaii

Commercial NCM Cathode Material for Li-Ion Batteries. Atomic EDS map. Overlay shows O (red), Ni (blue), Mn (green).

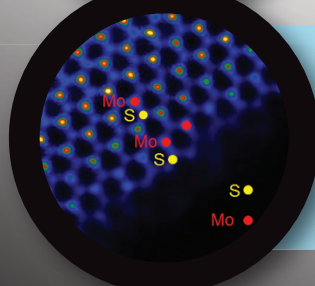
— 0.5nm



Dr. Miguel Jose Yacaman
University of Texas, San Antonio

Sample provided by Tour Lab, Rice University
Chiral Nanotube with parameters $n=10$ and $m=4$ (simulated and experimental).

— 0.5nm



Dr. Moon Kim
University of Texas, Dallas

STEM HAADF image of transferred MoS₂, showing Mo and S atom positions and their 2H stacking sequence.

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